International Rectifier

IRF740SPbF

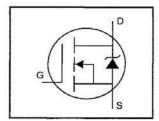
HEXFET® Power MOSFET

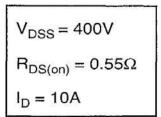
- Surface Mount
- · Available in Tape & Reel
- · Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

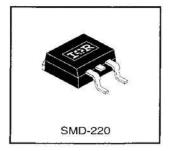
Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.







Absolute Maximum Ratings

SUMMER PROGRAMMED STREET	Parameter	Max.	Units	
Ip @ Tc = 25°C	Continuous Drain Current, VGS @ 10 V	10		
Ip @ Tc = 100°C	Continuous Drain Current, VGS @ 10 V	6.3	Α	
1 _{DM}	Pulsed Drain Current ①	40		
P _D @ T _C = 25°C	Power Dissipation	125	w	
PD @ TA = 25°C	Power Dissipation (PCB Mount)**	3.1	VV	
	Linear Derating Factor	1.0	W/°C	
	Linear Derating Factor (PCB Mount)**	0.025	VV/ C	
V _{GS}	Gate-to-Source Voltage	±20	V	
Eas	Single Pulse Avalanche Energy ②	520	mJ	
I _{AR}	Avalanche Current ①	10	Α	
EAR	Repetitive Avalanche Energy ①	13	mJ	
dv/dt	Peak Diode Recovery dv/dt ③	4.0	V/ns	
TJ, TSTG	Junction and Storage Temperature Range	-55 to +150 *	- °C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case))	

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Reuc	Junction-to-Case			1.0	
Reja	Junction-to-Ambient (PCB mount)**	11 -11	_	40	°C/W
Reja	Junction-to-Ambient	_	_	62	

^{**} When mounted on 1" square PCB (FR-4 or G-10 Material).
For recommended footprint and soldering techniques refer to application note #AN-994.

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	400	3 5	-	٧	V _{GS} =0V, I _D = 250μA	
ΔV _{(BR)DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	-	0.49	_	V/°C	Reference to 25°C, Ip= 1mA	
Ros(on)	Static Drain-to-Source On-Resistance	(Maria)	_	0.55	Ω	V _{GS} =10V, I _D =6.0A @	
V _{GS(th)}	Gate Threshold Voltage	2.0	_	4.0	٧	V _{DS} =V _{GS} , I _D = 250μA	
g _{ls}	Forward Transconductance	5.8	-	_	S	V _{DS} =50V, I _D =6.0A ④	
740	Drain-to-Source Leakage Current	=	_	25	μА	V _{DS} =400V, V _{GS} =0V	
loss	Diam-to-Source Leakage Current	_	_	250	μΑ	V _{DS} =320V, V _{GS} =0V, T _J =125°C	
lgss	Gate-to-Source Forward Leakage		-	100	nA	V _{GS} =20V	
IGSS	Gate-to-Source Reverse Leakage	_	//2/10 3	-100	1100	V _{GS} =-20V	
Qg	Total Gate Charge	-	_	63		I _D =10A	
Qgs	Gate-to-Source Charge			9.0	nC	V _{DS} =320V	
Q _{gd}	Gate-to-Drain ("Miller") Charge	-		32		V _{GS} =10V See Fig. 6 and 13 @	
t _{d(on)}	Turn-On Delay Time	-	14	_		V _{DD} =200V	
tr	Rise Time		27	-	ns	I _D =10A	
t _{d(off)}	Turn-Off Delay Time	-	50		1.0	R _G =9.1Ω	
tr	Fall Time		24	_		R _D =20Ω See Figure 10 @	
L _D	Internal Drain Inductance	_	4.5	<u></u>	DH.	nH Between lead, 6 mm (0.25in.) from package and center of die contact	
Ls	Internal Source Inductance	_	7.5	_	,,,,,		
Ciss	Input Capacitance		1400			V _{GS} =0V	
Coss	Output Capacitance	-	330	_	pF V _{DS} = 25V		
Crss	Reverse Transfer Capacitance	1	120			f=1.0MHz See Figure 5	

Source-Drain Ratings and Characteristics

54	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
ls	Continuous Source Current (Body Diode)		_	10	_	MOSFET symbol showing the	
Ism	Pulsed Source Current (Body Diode) ①	3-3-100 1 3 -3-1	=	40	A	integral reverse p-n junction diode.	
VsD	Diode Forward Voltage		_	2.0	٧	T _J =25°C, I _S =10A, V _{GS} =0V @	
t _{rr}	Reverse Recovery Time		370	790	ns	T _J =25°C, I _F =10A	
Qrr	Reverse Recovery Charge	-	3.8	8.2	μС	di/dt=100A/μs ④	
ton	Forward Turn-On Time	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+Lp					

Notes:

- Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ IsD≤10A, di/dt≤120A/ μ s, VDD≤V(BR)DSS, TJ≤150°C
- ② V_{DD}=50V, starting T_J=25°C, L=9.1mH R_G=25Ω, I_{AS}=10A (See Figure 12)
- ⓐ Pulse width ≤ 300 μ s; duty cycle ≤2%.

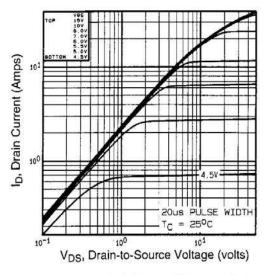


Fig 1. Typical Output Characteristics, Tc=25°C

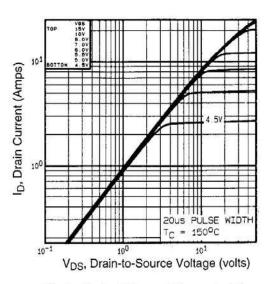


Fig 2. Typical Output Characteristics, T_C=150°C

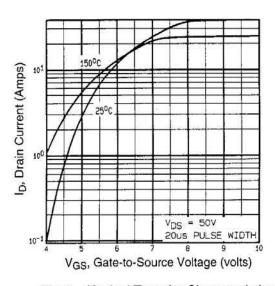


Fig 3. Typical Transfer Characteristics

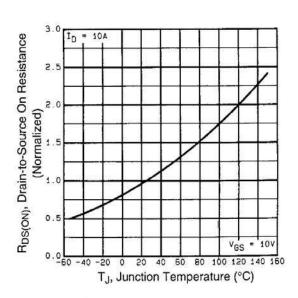


Fig 4. Normalized On-Resistance Vs. Temperature

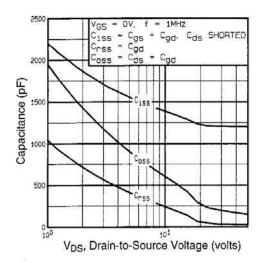


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

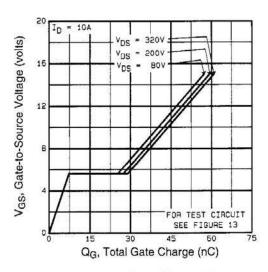


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

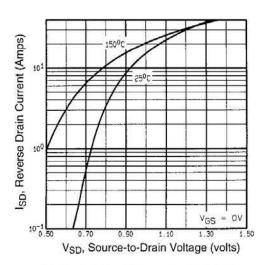


Fig 7. Typical Source-Drain Diode Forward Voltage

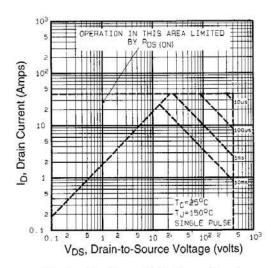


Fig 8. Maximum Safe Operating Area

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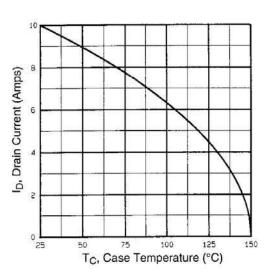


Fig 9. Maximum Drain Current Vs. Case Temperature

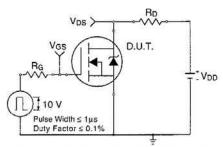


Fig 10a. Switching Time Test Circuit

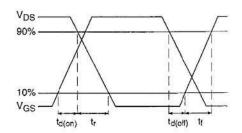


Fig 10b. Switching Time Waveforms

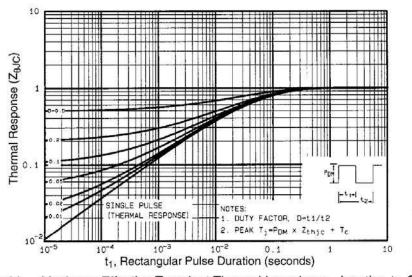


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

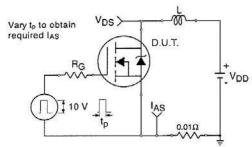


Fig 12a. Unclamped Inductive Test Circuit

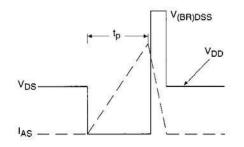


Fig 12b. Unclamped Inductive Waveforms

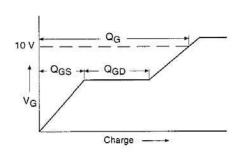


Fig 13a. Basic Gate Charge Waveform

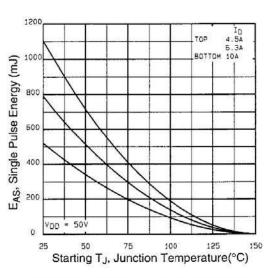


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

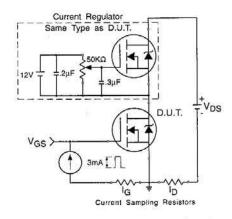


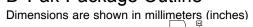
Fig 13b. Gate Charge Test Circuit

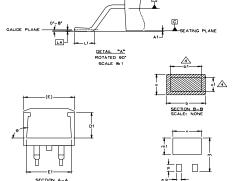
Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit

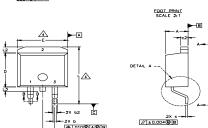
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D²Pak Package Outline







S	DIMENSIONS				Z
M B O	MILLIM	ETERS	INCHES		ZOHW
L	MIN.	MAX.	MIN.	MAX.	Š
Α	4.06	4.83	.160	.190	
Α1		0.127		.005	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	4
ь2	1.14	1.40	.045	.055	
С	0.43	0.63	.017	.025	
c1	0.38	0.74	.015	.029	4
c2	1,14	1,40	.045	.055	
D	8.51	9.65	.335	.380	3
D1	5.33		.210		
Ε	9.65	10.67	.380	.420	3
E1	6.22		.245		
e	2.54	BSC	.100	BSC	
L	14.61	15.88	.575	.625	
L1	1,78	2.79	.070	,110	
L2		1.65		.065	
L3	1.27	1.78	.050	.070	
L4	0,25	BSC	.010 BSC		
m	17.78		.700		
m1	8.89		.350		
n	11.43		.450		
0	2.08		.082		
Р	3.81		.150		
Θ	90.	93*	90.	93*	
				٠	

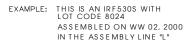
LEAD ASSIGNMENTS

HEXFET	IGBTs, CoPACK	DIODES		
1 GATE	1 GATE	1 ANODE 1		
2 DRAIN	2 COLLECTOR	2 CATHOD		
3 SOURCE	3 EMITTER	3 ANODE		

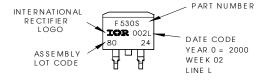


- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 5, CONTROLLING DIMENSION: INCH.

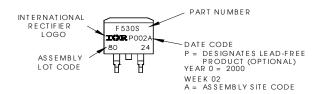
D²Pak Part Marking Information (Lead-Free)



Note: "P" in assembly line position indicates "Lead-Free"

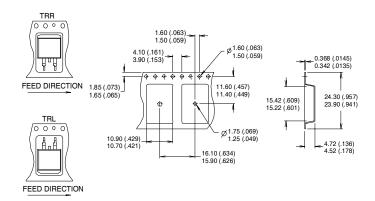


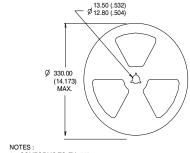
OR

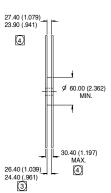


D²Pak Tape & Reel Infomation

Dimensions are shown in millimeters (inches)







- COMFORMS TO EIA-418.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION MEASURED @ HUB.
 INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.

International IOR Rectifier

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04/04



Vishay

Notice

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